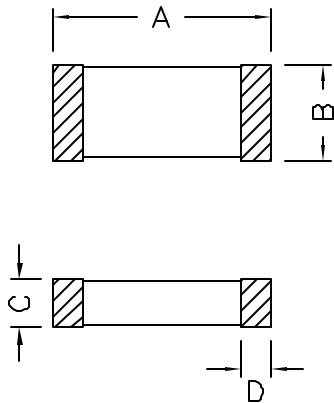


# XFMRS, Inc.

## SPECIFICATION FOR APPROVAL

XFMRS P/N : XFE1100505-6N8J				Rev: A/2		
<div style="text-align: center;">  </div>				A	1.0±0.1	m/m
				B	0.5±0.1	m/m
				C	0.5±0.1	m/m
				D	0.25±0.15	m/m
				E		m/m
				F		m/m
				G		m/m
				H		m/m
				I		m/m
				J		m/m
				K		m/m
				L		m/m
				M		m/m
				N		m/m
				O		m/m
ELECTRICAL REQUIREMENTS				TEST INSTRUMENTS		
L	6.8±5% nH	TEST FREQ.	100MHz/100mV	<ul style="list-style-type: none"> <li>● HP 34401A MULTIMETER</li> <li>○ HP 4195 NETWORKS/SPECTRUM ANALYZER</li> <li>○ HP 42841 BIAS CURRENT SOURCE</li> <li>○ HP 4285A LCR METER</li> <li>○ HP 4286A RF LCR METER</li> <li>● HP 4291A RF IMPEDANCE / MATERIAL ANALYZER</li> <li>○ HP 6632A DC POWER SUPPLY</li> </ul>		
Q	8 MIN.	TEST FREQ.	100MHz/100mV			
SRF	5000MHz MIN.	TEST FREQ.				
Rdc	0.32 Ohms Max.	TEST FREQ.				
Idc	250mA dc Max	TEST FREQ.				
		TEST FREQ.				
		TEST FREQ.				
		TEST FREQ.				
DRAWN BY :		CHECKED BY :		APPROVED BY :		
Xiany Jul-30-09		YK Liao Jul-30-09		Joe Huff Jul-30-09		